

SLOVENSKI STANDARD SIST EN 61240:2012

01-december-2012

Nadomešča: SIST EN 61240:2002

Piezoelektrični elementi - Priprava tehničnih risb površinsko montiranega elementa (SMD) za frekvenčno regulacijo in filtriranje - Splošna pravila

Piezoelectric devices - Preparation of outline drawings of surface-mounted device (SMD) for frequency control and selection - General rules

Piezoelektrische Bauelemente Anfertigung von Gehäusezeichnungen von oberflächenmontierbaren Bauelementen (SMDs) zur Frequenzstabilisierung und - Selektion - Allgemeine Regeln

SIST EN 61240:2012

Dispositifs piézoélectriques Préparation des dessins d'encombrement des dispositifs à montage en surface pour la commandé et le choix de la fréquence - Règles générales

Ta slovenski standard je istoveten z: EN 61240:2012

ICS:

31.140 Piezoelektrične in dielektrične naprave Piezoelectric and dielectric devices

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en



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Piezoelectric devices -Preparation of outline drawings of surface-mounted devices (SMD) for frequency control and selection -General rules

(IEC 61240:2012)

Dispositifs piézoélectriques -

Préparation des dessins d'encombrement des dispositifs à montage en surface pour la commande et le choix de la fréquence -Règles générales (CEI 61240:2012) **Trab** ST A ND A 1 Piezoelektrische Bauelemente -Anfertigung von Gehäusezeichnungen von oberflächenmontierbaren Bauelementen (SMD) zur Frequenz-Stabilisierung und -Selektion -

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CENELEC

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Foreword

The text of document 49/995/FDIS, future edition 2 of IEC 61240, prepared by IEC TC 49 "Piezoelectric, dielectric and electrostatic devices and associated materials for frequency control, selection and detection" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 61240:2012.

The following dates are fixed:

•	latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement	(dop)	2013-05-29
•	latest date by which the national standards conflicting with the document have to be withdrawn	(dow)	2015-08-29

This document supersedes EN 61240:1997.

EN 61240:2012 includes the following significant technical changes with respect to EN 61240:1997:

- outline drawings have been changed from three views (top, front and bottom) to that based on ISO layout in the third-angle projection, in which the view from the right has been added to the top, front and bottom views;

- reference line and geometrical dimensions of the package for enclosures have been changed for practical use;

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- information on miniaturized leadless ceramic enclosures of piezoelectric devices (SMD) for frequency control and selection has been included in an annex en-61240-2012

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Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

Publication	Year	Title	<u>EN/HD</u>	<u>Year</u>
IEC 60191-6	2009	Mechanical standardization of semiconductor devices - Part 6: General rules for the preparation of outline drawings of surface mounted semiconductor device packages	EN 60191-6	2009
ISO 128-30	2001	Technical drawings - General principles of presentation - Part 30: Basic conventions for views	-	-
ISO 1101	2004	Geometrical Product Specifications (GPS) - Geometrical tolerancing - Tolerances of form, orientation, location and run-out REVIE	EN ISO 1101	2005
ISO 5456-2	1996	Technical drawings - Projection methods - Part 2: Orthographic representations	EN ISO 5456-2	1999

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iTeh STANDARD PREVIEW (standards.iteh.ai)



Edition 2.0 2012-07

INTERNATIONAL STANDARD

NORME INTERNATIONALE

Piezoelectric devices of STANDARD PREVIEW

Preparation of outline drawings of surface-mounted devices (SMD) for frequency control and selection – General rules

SIST EN 61240:2012

Dispositifs piézoélectriques. a/catalog/standards/sist/a05a47e7-e20a-4bae-bd88-Préparation des dessins d'encombrément des dispositifs à montage en surface pour la commande et le choix de la fréquence – Règles générales

INTERNATIONAL ELECTROTECHNICAL COMMISSION

COMMISSION ELECTROTECHNIQUE INTERNATIONALE

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PIEZOELECTRIC DEVICES –

Preparation of outline drawings of surface-mounted devices (SMD) for frequency control and selection – General rules

FOREWORD

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International Standard IEC 61240 has been prepared by IEC technical committee 49: Piezoelectric, dielectric and electrostatic devices and associated materials for frequency control, selection and detection.

This second edition cancels and replaces the first edition published in 1994. It constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- outline drawings have been changed from three views (top, front and bottom) to that based on ISO layout in the third-angle projection, in which the view from the right has been added to the top, front and bottom views;
- reference line and geometrical dimensions of the package for enclosures have been changed for practical use;
- information on miniaturized leadless ceramic enclosures of piezoelectric devices (SMD) for frequency control and selection has been included in an annex.

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The text of this standard is based on the following documents:

FDIS	Report on voting
49/995/FDIS	49/1000/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

The enclosures of quartz crystal resonators and oscillators are unified in this second edition of IEC 61240 "Preparation of outline drawings of surface-mounted devices (SMD) for frequency control and selection – General rules".

Regarding the current situation of many quartz crystal device suppliers, many suppliers use their own enclosure layouts in their catalogues. For the convenience of consumers, general rules of enclosure layout and definition of size need to be unified.

In the previous edition of IEC 61240, layout rules of outline drawings of SMD devices were based on IEC 60191-6 and applied to semi-conductive devices. However, there are several specific rules for quartz devices. In this edition, the general rules for outline drawings of SMD enclosures for quartz crystal devices are included, taking account of the ISO layout rules (ISO 1101, ISO 5456-2, and ISO 128-30).

The newly proposed general rules of outline drawings for three types of surface-mounted devices are shown in sheets included as examples. The difference from the previous version of outline drawings is that one set of drawings consists of four views, which are the view from above, the front view, the view from the right, and the view from below.

Furthermore, the definition of the drawings has been changed. Firstly, ceramic enclosure is specifically defined. Secondly, the reference line of the package is defined as shown in the sheets. Thirdly, geometrical dimensions of the package have been further simplified compared to the previous edition. These corrections are shown in Annexes A and B of this standard.

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Detailed information concerning the new outline drawings will be provided in a future publication.